



DKZ/32/2011

Warsaw, 17.05.2011

**Re: The open procedure for the delivery of the mechanical profiler.**

With regard to the following questions:

1.

*Re: Terms of Reference, Appendix No. 1, point 9*

*Is it possible to propose the mechanical profilometer with vertical resolution of 1 Å?*

2.

*Re: Terms of Reference, Appendix No. 1, point 13*

*Is it possible to deliver equipment with stylus force adjustable from 1 to 15 mg for the first 6 months of usage?*

3.

*Re: Terms of Reference, Appendix No. 1, point 15*

*Is it possible to deliver equipment with optical system for sample preview which allow change of field of view from 1 mm to 4 mm as solution equal to required optical system with zoom adjustable at range 80 to 120x?*

4.

*Re: Terms of Reference, Appendix No. 1, point 17*

*Please specify exactly what test samples are required? Typically for this kind of equipment standard sample with step height = 88 nm is delivered for periodical profilometer calibration.*

we inform that:

Ad. 1, 2 and 3

*The Awarding Entity doesn't allow any changes in technical parameters of the device, specified at points 9, 13 and 15 of the Appendix No. 1 to the Terms of Reference.*

Ad. 4

Samples delivered for test should give possibility to check profilometer performance in wide range.

Sample with 88 nm step is suitable for small heights. Also sample with step height in range of hundreds micrometers should be delivered for tests.

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